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Applicant:

Walker, et al.

Serial No.:

10/721,147

Att'y Docket No.: 11675.102.2

Filing Date:

November 25, 2003

Art Unit: 2814 2822

For:

SACRIFICIAL SELF-ALIGNED INTERCONNECT  
STRUCTURE AND METHOD OF MAKING



INFORMATION DISCLOSURE CITATIONS MADE BY APPLICANT

U.S. Patent Documents

<u>Examiner Initial*</u>	<u>Document Number</u>	<u>Issue Date</u>	<u>Name</u>
MT	1 4,855,952	08/08/89	Kiyosumi
↑	2 5,077,688	12/31/91	Kumanoya, et al.
—	3 5,120,677	06/09/92	Wakamatsu
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MT	14 5,981,330	11/09/99	Jenq

Examiner:

Michael Trinh

Date Considered:

4/26/05

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OTHER DOCUMENTS

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References Cited by Applicants

While the filing of Information Disclosure Statements is voluntary, the procedure is governed by the guidelines of Section 609 of the Manual of Patent Examining Procedure and 37 C.F.R. §§ 1.97 and 1.98. To be considered a proper Information Disclosure Statement, Form PTO-1449 shall be accompanied by a copy of each listed patent or publication or other item of information and a translation of the pertinent portions of foreign documents (if an existing translation is readily available to the applicant), an explanation of relevance of each reference not in the English language, and should be submitted in a timely manner as set out in MPEP Sec. 609.

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The reference designations "A1," "A2," etc. (referring to Applicant's reference 1, Applicant's reference 2, etc.) will be used by the Examiner in the same manner as Examiner's reference designations "A," "B," "C," etc. on Office Action Form PTO-1142.

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Examiner: Michael Trinkl

Date Considered: 4/26/05

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